

SANYO Semiconductors **DATA SHEET**

LC87F1HC8SA-

CMOS IC
FROM 128K byte, RAM 16384 byte on-chip
8-bit 1-chip Microcontroller
with USB-host controller

Overview

The LC87F1HC8SA is an 8-bit microcomputer that, centered around a CPU running at a minimum bus cycle time of 83.3ns, integrates on a single chip a number of hardware features such as 128K-byte flash ROM (onboard programmable), 16384-byte RAM, an on-chip debugger, a sophisticated 16-bit timer/counter (may be divided into 8-bit timers), a 16-bit timer (may be divided into 8-bit timers or PWMs), four 8-bit timers with a prescaler, a base timer serving as a time-of-day clock, 3 channels of synchronous SIO interface with automatic data transfer capabilities, an asynchronous/synchronous SIO interface, a UART interface (full duplex), a full-speed USB interface (host control function), an 8-bit 12-channel AD converter, 2 channels of 12-bit PWM, a system clock frequency divider, an infrared remote control receiver circuit, and a 40-source 10-vector interrupt feature.

Features

- ■Flash ROM
 - Capable of on-board programming with a wide range of supply voltages: 3.0 to 5.5V
 - Block-erasable in 128 byte units
 - Writes data in 2-byte units
 - 131072×8 bits

■RAM

- 16384×9 bits
- ■Bus Cycle Time
 - 83.3ns (When CF=12MHz)

Note: The bus cycle time here refers to the ROM read speed.

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TOKYO OFFICE Tokyo Bldg., 1-10, 1 Chome, Ueno, Taito-ku, TOKYO, 110-8534 JAPAN

- ■Minimum Instruction Cycle Time (tCYC)
 - 250ns (When CF=12MHz)

■Ports

• I/O ports

Ports whose I/O direction can be designated in 1-bit units 28 (P10 to P17, P20 to P27, P30 to P34,

P70 to P73, PWM0, PWM1, XT2)

Ports whose I/O direction can be designated in 4-bit units 8 (P00 to P07)

• USB ports 2 (UHD+, UHD-)

• Dedicated oscillator ports 2 (CF1, CF2)

Input-only port (also used for oscillation)
 Reset pins
 1 (XT1)
 RES)

• Power supply pins 6 (VSS1 to 3, VDD1 to 3)

■Timers

• Timer 0: 16-bit timer/counter with 2 capture registers.

Mode 0: 8-bit timer with an 8-bit programmable prescaler (with two 8-bit capture registers) \times 2 channels

Mode 1: 8-bit timer with an 8-bit programmable prescaler (with two 8-bit capture registers)

+ 8-bit counter (with two 8-bit capture registers)

Mode 2: 16-bit timer with an 8-bit programmable prescaler (with two 16-bit capture registers)

Mode 3: 16-bit counter (with two 16-bit capture registers)

• Timer 1: 16-bit timer/counter that supports PWM/toggle outputs

Mode 0: 8-bit timer with an 8-bit prescaler (with toggle outputs) + 8-bit timer/

counter with an 8-bit prescaler (with toggle outputs)

Mode 1: 8-bit PWM with an 8-bit prescaler × 2 channels

Mode 2: 16-bit timer/counter with an 8-bit prescaler (with toggle outputs)

(toggle outputs also possible from lower-order 8 bits)

Mode 3: 16-bit timer with an 8-bit prescaler (with toggle outputs)

(lower-order 8 bits may be used as a PWM output)

- Timer 4: 8-bit timer with a 6-bit prescaler
- Timer 5: 8-bit timer with a 6-bit prescaler
- Timer 6: 8-bit timer with a 6-bit prescaler (with toggle outputs)
- Timer 7: 8-bit timer with a 6-bit prescaler (with toggle outputs)
- Base timer
 - 1) The clock is selectable from the subclock (32.768kHz crystal oscillation), system clock, and timer 0 prescaler output.
 - 2) Interrupts programmable in 5 different time schemes

■SIO

- SIO0: Synchronous serial interface
 - 1) LSB first/MSB first mode selectable
 - 2) Transfer clock cycle: 4/3 to 512/3 tCYC
 - 3) Automatic continuous data transmission (1 to 256 bits, specifiable in 1-bit units) (Suspension and resumption of data transmission possible in 1 byte units)
- SIO1: 8-bit asynchronous/synchronous serial interface
 - Mode 0: Synchronous 8-bit serial I/O (2- or 3-wire configuration, 2 to 512 tCYC transfer clocks)
 - Mode 1: Asynchronous serial I/O (half-duplex, 8 data bits, 1 stop bit, 8 to 2048 tCYC baudrates)
 - Mode 2: Bus mode 1 (start bit, 8 data bits, 2 to 512 tCYC transfer clocks)
 - Mode 3: Bus mode 2 (start detect, 8 data bits, stop detect)
- SIO4: Synchronous serial interface
 - 1) LSB first/MSB first mode selectable
 - 2) Transfer clock cycle: 4/3 to 1020/3 tCYC
 - 3) Automatic continuous data transmission (1 to 4096 bytes, specifiable in 1 byte units) (Suspension and resumption of data transmission possible in 1 byte units or in word units)
 - 4) Auto-start-on-falling-edge function
 - 5) Clock polarity selectable
 - 6) CRC16 calculator circuit built in

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- SIO9: Synchronous serial interface
 - 1) LSB first/MSB first mode selectable
 - 2) Transfer clock cycle: 4/3 to 1020/3 tCYC
 - 3) Automatic continuous data transmission (1 to 4096 bytes, specifiable in 1 byte units) (Suspension and resumption of data transmission possible in 1 byte units or word units)
 - 4) Auto-start-on-falling-edge function
 - 5) Clock polarity selectable
 - 6) CRC16 calculator circuit built in

■Full Duplex UART

1) Data length: 7/8/9 bits selectable

2) Stop bits: 1 bit (2 bits in continuous transmission mode)

3) Baud rate: 16/3 to 8192/3 tCYC

■AD Converter: 8 bits × 12 channels

■PWM: Multifrequency 12-bit PWM × 2 channels

■Infrared Remote Control Receiver Circuit

- 1) Noise rejection function (noise filter time constant: Approx. 120µs when the 32.768kHz crystal oscillator is selected as the base clock)
- 2) Supports data encoding systems such as PPM (Pulse Position Modulation) and Manchester encoding.
- 3) X'tal HOLD mode reset function

■USB Interface (host control function)

- 1) Compliant with full-speed (12M bps) specifications
- 2) Supports 4 transfer types (control transfer, bulk transfer, interrupt transfer, and isochronous transfer).

■Audio Interface

1) Sampling frequency (fs): 32kHz, 44.1kHz, 48kHz

2) Master clock frequency (internal PLL): 12.288MHz, 16.9344MHz, 18.432MHz

3) Bit clock selectable: 48fs/64fs 4) Data bit length: 16/18/20/24 bits

5) LSB first/MSB firsts selectable

6) Left-justification/right-justification selectable

■Watchdog Timer

- Watchdog timer using external RC circuitry
- Interrupt and reset signals selectable

■Clock Output Function

- 1) Can output a clock with a clock rate of 1/1, 1/2, 1/4, 1/8, 1/16, 1/32, or 1/64 of the source oscillator clock selected as the system clock.
- 2) Can output the source oscillation clock for the subclock.

■Interrupts

- 40 sources, 10 vector addresses
 - 1) Provides three levels (low (L), high (H), and highest (X)) of multiplex interrupt control. Any interrupt requests of the level equal to or lower than the current interrupt are not accepted.
- 2) When interrupt requests to two or more vector addresses occur at the same time, the interrupt of the highest level takes precedence over the other interrupts. For interrupts of the same level, the interrupt into the smallest vector address takes precedence.

No.	Vector Address	Level	Interrupt Source
1	00003H	X or L	INT0
2	0000BH	X or L	INT1
3	00013H	H or L	INT2/T0L/INT4/UHC bus active/remote control signal receive
4	0001BH	H or L	INT3/INT5/base timer
5	00023H	H or L	T0H/INT6/UHC device connected/UHC disconnected/UHC resume
6	0002BH	H or L	T1L/T1H/INT7/SIO9/AIF start
7	00033H	H or L	SIO0/UART1 receive
8	0003BH	H or L	SIO1/SIO4/UART1 transmit/end of AIF
9	00043H	H or L	ADC/T6/T7/UHC-ACK/UHC-NAK/UHC error/UHC STALL
10	0004BH	H or L	Port 0/PWM0/PWM1/T4/T5/UHC-SOF/DMCOPY

- Priority levels X > H > L
- Of interrupts of the same level, the one with the smallest vector address takes precedence.
- ■Subroutine Stack Levels: 8192 levels maximum (The stack is allocated in RAM.)
- ■High-speed Multiplication/Division Instructions

16 bits × 8 bits
24 bits × 16 bits
16 bits ÷ 8 bits
24 bits ÷ 16 bits
16 bits ÷ 8 bits
16 bits ÷ 16 bits
17 tCYC execution time
18 tCYC execution time
19 tCYC execution time
10 tCYC execution time
10 tCYC execution time
11 tCYC execution time
12 tCYC execution time
13 tCYC execution time
14 tCYC execution time
15 tCYC execution time
16 tCYC execution time
17 tCYC execution time
18 tCYC execution time
19 tCYC execution time
10 tCYC execution time

■Oscillation and PLL Circuits

RC oscillation circuit (internal): For system clock
 CF oscillation circuit: For system clock

• Crystal oscillation circuit: For system clock, time-of-day clock

• PLL circuit (internal): For USB interface (see Fig. 5)), audio interface (see Fig. 6)

■Standby Function

- HALT mode: Halts instruction execution while allowing the peripheral circuits to continue operation.
 - 1) Oscillation is not halted automatically.
 - 2) Canceled by a system reset or occurrence of an interrupt.
- HOLD mode: Suspends instruction execution and the operation of the peripheral circuits.
 - 1) The PLL base clock generator, CF, RC and crystal oscillators automatically stop operation.
 - 2) There are four ways of resetting the HOLD mode.
 - (1) Setting the reset pin to the lower level.
 - (2) Setting at least one of the INT0, INT1, INT2, INT4, and INT5 pins to the specified level
 - (3) Having an interrupt source established at port 0
 - (4) Having an bus active interrupt source established in the USB host controll circuit
- X'tal HOLD mode: Suspends instruction execution and the operation of the peripheral circuits except the base timer.
 - 1) The PLL base clock generator, CF and RC oscillator automatically stop operation.
 - 2) The state of crystal oscillation established when the X'tal HOLD mode is entered is retained.
 - 3) There are six ways of resetting the X'tal HOLD mode.
 - (1) Setting the reset pin to the low level
 - (2) Setting at least one of the INT0, INT1, INT2, INT4, and INT5 pins to the specified level
 - (3) Having an interrupt source established at port 0
 - (4) Having an interrupt source established in the base timer circuit
 - (5) Having an bus active interrupt source established in the USB host controll circuit
 - (6) Having an interrupt source established in the infrared remote controller receiver circuit

■Package Form

• SQFP48(7×7): Lead-free type

■Development Tools

• On-chip debugger: TCB87- type-B + LC87F1HC8A

■Flash ROM Programming Boards

Package	Programming boards
SQFP48(7 × 7)	W87F55256SQ

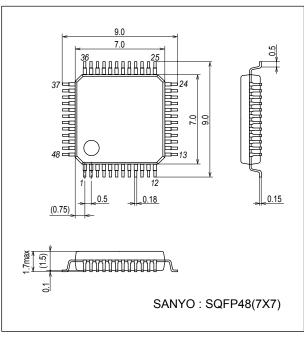
■Recommended EPROM Programmer

Maker	Maker Model		Device	
Flash Support Group, Inc.	AF9708/AF9709/AF9709B/AF9709C	After Rev02.82	LC87F1HC8A	
(Single)	(including products from Ando Electric Co., Ltd.)	Alter Revoz.82	LC0/FINC0A	
SANYO	SKK/SKK TypeB/SKK-DBG TypeB	Application Version: After 2.04	1.007541100	
SANYU	(SANYO FWS)	Chip Data Version: After 2.11	LC87F1HC8	

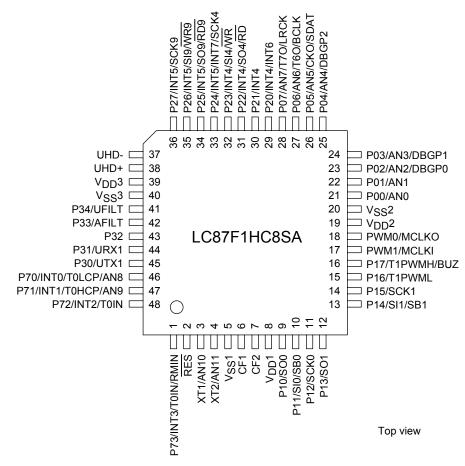
Package Dimensions

unit: mm (typ)

3163B



Pin Assignment

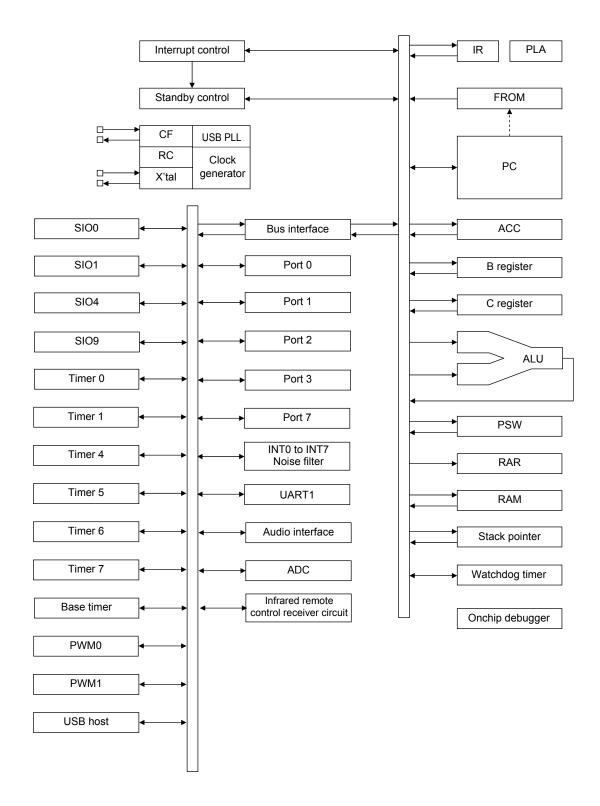


SANYO: SQFP48(7×7) "Lead-free Type"

SQFP48	NAME
1	P73/INT3/T0IN/RMIN
2	RES
3	XT1/AN10
4	XT2/AN11
5	V _{SS} 1
6	CF1
7	CF2
8	V _{DD} 1
9	P10/SO0
10	P11/SI0/SB0
11	P12/SCK0
12	P13/SO1
13	P14/SI1/SB1
14	P15/SCK1
15	P16/T1PWML
16	P17/T1PWMH/BUZ
17	PWM1/MCLKI
18	PWM0/MCLKO
19	V _{DD} 2
20	V _{SS} 2
21	P00/AN0
22	P01/AN1
23	P02/AN2/DBGP0
24	P03/AN3/DBGP1

SQFP48	NAME
25	P04/AN4/DBGP2
26	P05/AN5/CKO/SDAT
27	P06/AN6/T6O/BCLK
28	P07/AN7/T7O/LRCK
29	P20/INT4/INT6
30	P21/INT4
31	P22/INT4/SO4/RD
32	P23/INT4/SI4/WR
33	P24/INT5/INT7/SCK4
34	P25/INT5/SO9/RD9
35	P26/INT5/SI9/WR9
36	P27/INT5/SCK9
37	UHD-
38	UHD+
39	$V_{\mathrm{DD}}3$
40	V _{SS} 3
41	P34/UFILT
42	P33/AFILT
43	P32
44	P31/URX1
45	P30/UTX1
46	P70/INT0/T0LCP/AN8
47	P71/INT1/T0HCP/AN9
48	P72/INT2/T0IN

System Block Diagram



Pin Description

Pin Name	I/O			De	escription			Option			
V _{SS} 1,V _{SS} 2,	-	- power supply						No			
V_{SS}^3											
V _{DD} 1, V _{DD} 2	-	+ power supply	1 111								
V _{DD} 3	-	USB reference	voltage					Yes			
Port 0	I/O	• 8-bit I/O ports						Yes			
P00 to P07		I/O specifiable	e in 4-bit units								
		-	Pull-up resistors can be turned on and off in 4-bit units.								
			HOLD reset input								
		Port 0 interrup	ot input								
		Pin functions AD converter	input ports: AN0) to AN7/P00 to	P07)						
			ger pins: DBGP		•						
				•	AT input/output						
		_	•		CLK input/output						
		P07: Timer 7 t	toggle output/au	idio interface LF	RCK input/output						
Port 1	I/O	8-bit I/O ports						Yes			
P10 to P17		I/O specifiable									
		Pull-up resistor	ors can be turne	d on and off in	1-bit units.						
		Pin functions P10: SIO0 det	in autout	D	IA: CIOA data inni	.t/b					
		P10: SIO0 dat	ia output ia input/bus inpt		14: SIO1 data inpu 15: SIO1 clock inp		uı				
			ck input/output	-	16: Timer 1 PWML	•					
		P13: SIO1 dat			17: Timer 1 PWM	•	output				
Port 2	I/O	8-bit I/O ports	•				•	Yes			
P20 to P27		I/O specifiable	e in 1-bit units								
		Pull-up resistor	Pull-up resistors can be turned on and off in 1-bit units.								
		Pin functions	• Pin functions								
				•	er 1 event input/ti	mer 0L capture i	nput/				
			mer 0H capture	•	4						
			mer 0H capture	•	er 1 event input/ti	mer oL capture i	npuv				
			ut/timer 0L capt	-							
			ta input/output/p	•	RD output						
			ta input/output/p		•						
					r 0H capture 1 inp	out					
			a input/output/p								
			a input/output/p	arallel interface	WR9 output						
			ck input/output								
	1	interrupt ackn	owledge types		Dioing 0						
			Rising	Falling	Rising & Falling	H level	L level				
		INT4	enable	enable	enable	disable	disable				
		INT5	enable	enable	enable	disable	disable				
	1										
		INT6	enable	enable	enable	disable	disable				
	1	INT7	enable	enable	enable	disable	disable				
Port 3	I/O	• 5-bit I/O ports						Yes			
P30 to P34	- "	I/O specifiable						163			
1 JU IU F J4	1	Pull-up resistor		d on and off in	1-bit units.						
		Pin functions			-						
		P30: UART1 t	ransmit								
	1	P31: UART1 r	eceive								
			erface PLL filter	-	•						
		P34: USB inte	rface PLL filter	pin (see Fig. 5.)			tinued on next page			

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Pin Name	I/O			Des	cription			Option
Port 7	I/O	• 4-bit I/O port						No
P70 to P73		I/O specifiable i	n 1-bit units					
		Pull-up resistors	s can be turned	on and off in 1-	oit units.			
		Pin functions						
		•			ture input/watch	dog timer output		
		P71: INT1 input			•			
		•			t input/timer 0L o	capture input/		
			d clock counter	-			.,	
				•	event input/timer	OH capture inpi	ut/	
			controller receiv	•				
		AD converter in Interrupt acknow		P70), AN9(P71)				
		interrupt acknow	wiedge types		Rising &			
			Rising	Falling	Falling &	H level	L level	
		INT0	enable	enable	disable	enable	enable	
		INT1	enable	enable	disable	enable	enable	
		INT2	enable	enable	enable	disable	disable	
		INT3	enable	enable	enable	disable	disable	
PWM0	I/O	PWM0, PWM1 or	utput port					No
PWM1		General-purpose input port						
		Pin functions						
		PWM0: Audio ir	nterface master	clock output				
		PWM1: Audio ir	nterface master	clock input				
UHD-	I/O	USB data I/O pin	ا-UHD-/general	purpose I/O port				No
UHD+	I/O	USB data I/O pin	UHD+/general-	purpose I/O por	t			No
RES	Input	Reset pin						No
XT1	Input	• 32.768kHz crys	tal oscillator inp	out				No
		Pin functions						
		General-purpos						
		AD converter in						
		Must be connec			ed.			1
XT2	I/O	• 32.768kHz crys	tal oscillator out	tput				No
		Pin functions	. 1/0					
		General-purpos						
		AD converter in		cont open if not	to be used			
CF1	Input	Must be set for		rehr obeu it uot	o pe usea.			No
CF2	Output	Ceramic/crystal r						No
OI 2	Output	Ceramic/crystal r	esonator output	l .				INU

Port Output Types

The table below lists the types of port outputs and the presence/absence of a pull-up resistor.

Data can be read into any input port even if it is in the output mode.

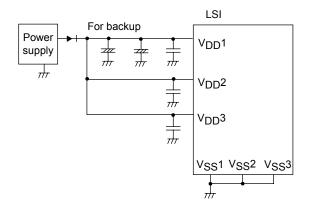
Port Name	Option Selected in Uunits of	Option Type	Output Type	Pull-up Resistor
P00 to P07	1 bit	1	CMOS	Programmable (Note 1)
		2	Nch-open drain	No
P10 to P17	1 bit	1	CMOS	Programmable
P20 to P27 P30 to P34		2	Nch-open drain	Programmable
P70	-	No	Nch-open drain	Programmable
P71 to P73	-	No	CMOS	Programmable
PWM0, PWM1	-	No	CMOS	No
UHD+, UHD-	-	No	CMOS	No
XT1	-	No	Input only	No
XT2	-	No	32.768kHz crystal resonator output (N channel open	No
			drain when in general-purpose output mode)	

Note 1: Programmable pull-up resistors for port 0 are controlled in 4 bit units (P00 to 03, P04 to 07).

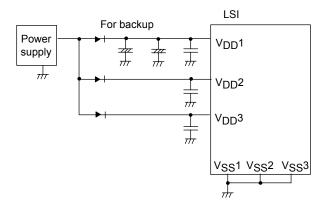
Power Pin Treatment

Connect the IC as shown below to minimize the noise input to the V_{DD1} pin. and extend the backup period. Be sure to electrically short the V_{SS1} , V_{SS2} , and V_{SS3} pins.

Example 1: When the microcontroller is in the backup state in the HOLD mode, the power to sustain the high level of output ports is supplied by their backup capacitors.



Example 2: The high level output at ports is not sustained and unstable in the HOLD backup mode.



USB Reference Power Option

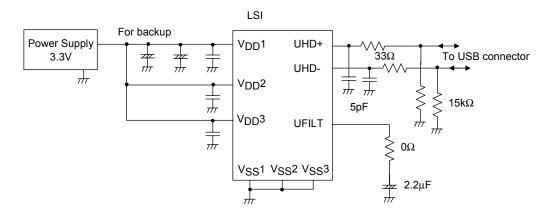
When a voltage 4.5 to 5.5V is supplied to V_{DD}1 and the internal USB reference voltage circuit is activated, the reference voltage for USB port output is generated. The active/inactive state of the reference voltage circuit can be switched by option select. The procedure for marking the option selection is described below.

		(1)	(2)	(3)	(4)
Option settings	USB regulator	USE	USE	USE	NONUSE
	USB regulator at HOLD mode	USE	NONUSE	NONUSE	NONUSE
	USB regulator at HALT mode	USE	NONUSE	USE	NONUSE
Reference voltage circuit state	Normal mode	active	active	active	inactive
	HOLD mode	active	inactive	inactive	inactive
	HALT mode	active	inactive	active	inactive

- When the USB reference voltage circuit is made inactive, the level of the reference voltage for USB port output is equal to V_{DD}1.
- Selection (2) or (3) can be used to set the reference voltage circuit inactive in HOLD or HALT mode.
- When the reference voltage circuit is activated, the current drain increases by approximately 100µA compared with when the reference voltage circuit is inactive.

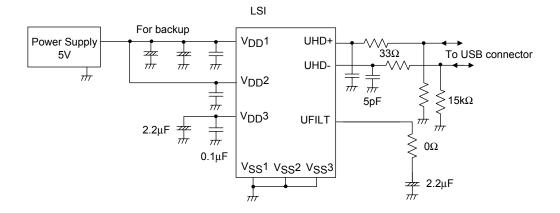
Example 1: $V_{DD}1=V_{DD}2=3.3V$

- Inactivating the reference voltage circuit (selection (4)).
- Connecting V_{DD}3 to V_{DD}1 and V_{DD}2.



Example 2: VDD1=VDD2=5.0V

- Activating the reference voltage circuit (selection (1)).
- Isolating VDD3 from VDD1 and VDD2, and connecting capacitor between VDD3 and VSS.



Absolute Maximum Ratings at Ta = 25°C, $V_{SS}1 = V_{SS}2 = V_{SS}3 = 0V$

	1			- 00-				
Paramete	er Symbol	Pin/Remarks	Conditions	V D.0	:	Specifi		
Maximum sup	pply V _{DD} max	V _{DD} 1, V _{DD} 2, V _{DD} 3	V _{DD} 1= V _{DD} 2= V _{DD} 3	V _{DD} [V]	min -0.3	typ	+6.5	unit
voltage Input voltage	V _I (1)	XT1, CF1			-0.3		V _{DD} +0.3	
Input/output voltage	V _{IO} (1)	Ports 0, 1, 2, 3, 7 PWM0, PWM1 XT2			-0.3		V _{DD} +0.3	V
Peak out current	tput IOPH(1)	Ports 0, 1, 2	When CMOS output type is selected Per 1 applicable pin		-10			
	IOPH(2)	PWM0, PWM1	Per 1 applicable pin		-20			
	IOPH(3)	Port 3 P71 to P73	When CMOS output type is selected Per 1 applicable pin		-5			
Average output cu	urrent	Ports 0, 1, 2	When CMOS output type is selected Per 1 applicable pin		-7.5			
nt cn	IOMH(2)	PWM0, PWM1	Per 1 applicable pin		-15			
(Note 1-1	IOMH(3)	Port 3 P71 to P73	When CMOS output type is selected Per 1 applicable pin		-3			
Total out	tput ΣΙΟΑΗ(1)	Ports 0, 2	Total current of all applicable pins		-25			
	ΣΙΟΑΗ(2)	Port 1 PWM0, PWM1	Total current of all applicable pins		-25			
	ΣΙΟΑΗ(3)	Ports 0, 1, 2 PWM0, PWM1	Total current of all applicable pins		-45			
	ΣΙΟΑΗ(4)	Port 3 P71 to P73	Total current of all applicable pins		-10			
	ΣΙΟΑΗ(5)	UHD+, UHD-	Total current of all applicable pins		-25			mA
Peak out current	tput IOPL(1)	P02 to P07 Ports 1, 2 PWM0, PWM1	Per 1 applicable pin				20	
	IOPL(2)	P00, P01	Per 1 applicable pin				30	
	IOPL(3)	Ports 3, 7 XT2	Per 1 applicable pin				10	
Average output cu	urrent	P02 to P07 Ports 1, 2 PWM0, PWM1	Per 1 applicable pin				15	
it cur	IOML(2)	P00, P01	Per 1 applicable pin				20	
(Note 1-1	IOML(3)	Ports 3, 7 XT2	Per 1 applicable pin				7.5	
Total out	tput ΣΙΟΑL(1)	Ports 0, 2	Total current of all applicable pins				45	
	ΣIOAL(2)	Port 1 PWM0, PWM1	Total current of all applicable pins				45	
	ΣIOAL(3)	Ports 0, 1, 2 PWM0, PWM1	Total current of all applicable pins				80	
	ΣIOAL(4)	Ports 3, 7 XT2	Total current of all applicable pins				15	
	ΣIOAL(5)	UHD+, UHD-	Total current of all applicable pins				25	
Allowable povidissipation	wer Pd max	SQFP48(7×7)	Ta=-40 to +85°C				140	mW
Operating am temperature	nbient Topr				-40		+85	°C
Storage ambi	ient Tstg							

Note 1-1: The average output current is an average of current values measured over 100ms intervals.

Allowable Operating Conditions at Ta = -40 °C to +85 °C, $V_SS1 = V_SS2 = V_SS3 = 0V$

Barranta	0	D'a (Danas da	O a a fifth a ca			Specific	ation	
Parameter	Symbol	Pin/Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
Operating	V _{DD} (1)	V _{DD} 1=V _{DD} 2=V _{DD} 3	0.245μs ≤ tCYC ≤ 200μs		3.0		5.5	
supply voltage (Note 2-1)			0.490µs ≤ tCYC ≤ 200µs Except in onboard programming mode		2.7		5.5	
Memory sustaining supply voltage	VHD	V _{DD} 1=V _{DD} 2=V _{DD} 3	RAM and register contents sustained in HOLD mode.		2.0		5.5	
High level input voltage	V _{IH} (1)	Ports 0, 1, 2, 3 P71 to P73 P70 port input/ interrupt side PWM0, PWM1		2.7 to 5.5	0.3V _{DD} +0.7		V _{DD}	
	V _{IH} (2)	Port 70 watchdog timer side		2.7 to 5.5	0.9V _{DD}		V _{DD}]
	V _{IH} (3)	XT1, XT2, CF1, RES		2.7 to 5.5	0.75V _{DD}		V_{DD}	V
Low level input voltage	V _{IL} (1)	Ports 1, 2, 3 P71 to P73		4.0 to 5.5	V _{SS}		0.1V _{DD} +0.4	
	V _{IL} (2)	P70 port input/ interrupt side		2.7 to 4.0	V _{SS}		0.2V _{DD}	
	V _{IL} (3)	Port 0 PWM0, PWM1		4.0 to 5.5	V _{SS}		0.15V _{DD} +0.4	
	V _{IL} (4)			2.7 to 4.0	V _{SS}		0.2V _{DD}	
	V _{IL} (5)	Port 70 watchdog timer side		2.7 to 5.5	V _{SS}		0.8V _{DD} -1.0	
	V _{IL} (6)	XT1, XT2, CF1, RES		2.7 to 5.5	V _{SS}		0.25V _{DD}	
Instruction	tCYC			3.0 to 5.5	0.245		200	
cycle time (Note 2-2)			Except for onboard programming mode	2.7 to 5.5	0.490		200	μs
External system clock frequency	FEXCF(1)	CF1	CF2 pin open System clock frequency division ratio=1/1 External system clock duty =50±5%	3.0 to 5.5	0.1		12	
			CF2 pin open System clock frequency division ratio=1/1 External system clock duty =50±5%	2.7 to 5.5	0.1		6	MHz
Oscillation frequency	FmCF(1)	CF1, CF2	When 12MHz ceramic oscillation See Fig. 1.	3.0 to 5.5		12		
range (Note 2-3)	FmCF(2)	CF1, CF2	When 6MHz ceramic oscillation See Fig. 1.	2.7 to 4.5		6		MHz
•	FmRC		Internal RC oscillation	2.7 to 5.5	0.3	1.0	2.0	
	FsX'tal	XT1, XT2	32.768kHz crystal oscillation See Fig. 2.	2.7 to 5.5		32.768		kHz

Note 2-1: V_{DD} must be held greater than or equal to 3.0V in the flash ROM onboard programming mode.

Note 2-3: See Tables 1 and 2 for the oscillation constants.

Note 2-2: Relationship between tCYC and oscillation frequency is 3/FmCF at a division ratio of 1/1 and 6/FmCF at a division ratio of 1/2.

Electrical Characteristics at $Ta = -40^{\circ}C$ to $+85^{\circ}C$, $V_{SS}1 = V_{SS}2 = V_{SS}3 = 0V$

Parameter Symbol Pin/Remarks Conditions		Conditions			Specifica	ition		
Farameter	Symbol	FIII/Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
High level input current	I _{IH} (1)	Ports 0, 1, 2, 3 Port 7 RES PWM0, PWM1 UHD+, UHD-	Output disabled Pull-up resistor off VIN=VDD (Including output Tr's off leakage current)	2.7 to 5.5			1	
	I _{IH} (2)	XT1, XT2	Input port configuration V _{IN} =V _{DD}	2.7 to 5.5			1	
	I _{IH} (3)	CF1	V _{IN} =V _{DD}	2.7 to 5.5			15	
Low level input current	I _{IL} (1)	Ports 0, 1, 2, 3 Port 7 RES PWM0, PWM1 UHD+, UHD-	Output disabled Pull-up resistor off VIN=VSS (Including output Tr's off leakage current)	2.7 to 5.5	-1			μΑ
	I _{IL} (2)	XT1, XT2	Input port configuration VIN=VSS	2.7 to 5.5	-1			
	I _{IL} (3)	CF1	V _{IN} =V _{SS}	2.7 to 5.5	-15			
High level output	V _{OH} (1)	Ports 0, 1, 2, 3	I _{OH} =-1mA	4.5 to 5.5	V _{DD} -1			
voltage	V _{OH} (2)	P71 to P73	I _{OH} =-0.4mA	3.0 to 5.5	V _{DD} -0.4			
	V _{OH} (3)		I _{OH} =-0.2mA	2.7 to 5.5	V _{DD} -0.4			
	V _{OH} (4)	PWM0, WM1	I _{OH} =-10mA	4.5 to 5.5	V _{DD} -1.5			
	V _{OH} (5)	P05 to P07	I _{OH} =-1.6mA	3.0 to 5.5	V _{DD} -0.4			
	V _{OH} (6)	(Note 3-1)	I _{OH} =-1mA	2.7 to 5.5	V _{DD} -0.4			
Low level output	V _{OL} (1)	P00, P01	I _{OL} =30mA	4.5 to 5.5			1.5	V
voltage	V _{OL} (2)		I _{OL} =5mA	3.0 to 5.5			0.4	V
	V _{OL} (3)		I _{OL} =2.5mA	2.7 to 5.5			0.4	
	V _{OL} (4)	Ports 0, 1, 2	I _{OL} =10mA	4.5 to 5.5			1.5	
	V _{OL} (5)	PWM0, PWM1	I _{OL} =1.6mA	3.0 to 5.5			0.4	
	V _{OL} (6)	XT2	I _{OL} =1mA	2.7 to 5.5			0.4	
	V _{OL} (7)	Ports 3, 7	I _{OL} =1.6mA	3.0 to 5.5			0.4	
	V _{OL} (8)		I _{OL} =1mA	2.7 to 5.5			0.4	
Pull-up resistance	Rpu(1)	Ports 0, 1, 2, 3	V _{OH} =0.9V _{DD}	4.5 to 5.5	15	35	80	kΩ
	Rpu(2)	Port 7		2.7 to 5.5	18	50	150	K22
Hysteresis voltage	VHYS	RES Port 1, 2, 3, 7		2.7 to 5.5		0.1V _{DD}		V
Pin capacitance	СР	All pins	For pins other than that under test: VIN=VSS f=1MHz Ta=25°C	2.7 to 5.5		10		pF

Note 3-1: When the CKO system clock output function (P05) or audio interface output function (P05 to P07) is used.

Serial I/O Characteristics at Ta = -40 °C to +85 °C, $V_{SS}1 = V_{SS}2 = V_{SS}3 = 0$ V

1. SIO0 Serial I/O Characteristics (Note 4-1-1)

	-	Darameter	Cumbal	Pin/	Conditions			Spec	ification	
	F	Parameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
		Frequency	tSCK(1)	SCK0(P12)	See Fig. 8.		2			
		Low level pulse width	tSCKL(1)				1			
		High level pulse width	tSCKH(1)				1			
	clock		tSCKHA(1a)		Continuous data transfer mode USB, AIF, SIO4, SIO9, and DMCOPY not used at the same time. See Fig. 8. (Note 4-1-2)		4			
	Input clock		tSCKHA(1b)		Continuous data transfer mode USB used at the same time. AIF, SIO4, SIO9, and DMCOPY not used at the same time. See Fig. 8. (Note 4-1-2)	2.7 to 5.5	7			tCYC
ck			tSCKHA(1c)		Continuous data transfer mode USB, AIF, SIO4, SIO9, and DMCOPY used at the same time. See Fig. 8. (Note 4-1-2)		9			
Serial clock		Frequency	tSCK(2)	SCK0(P12)	When CMOS output type is selected		4/3			
Š		Low level pulse width	tSCKL(2)		• See Fig. 8.			1/2		
		High level pulse width	tSCKH(2)					1/2		tSCK
	clock	puise widui	tSCKHA(2a)		Continuous data transfer mode USB, AIF, SIO4, SIO9, and DMCOPY not used at the same time. When CMOS output type is selected See Fig. 8.		tSCKH(2) +2tCYC		tSCKH(2) + (10/3)tCYC	
	Output clock		tSCKHA(2b)		Continuous data transfer mode USB used at the same time. AIF, SIO4, SIO9, and DMCOPY not used at the same time. When CMOS output type is selected. See Fig. 8.	- 2.7 to 5.5	tSCKH(2) +2tCYC		tSCKH(2) + (19/3)tCYC	tCYC
			tSCKHA(2c)		Continuous data transfer mode USB, AIF, SIO4, SIO9, and DMCOPY used at the same time When CMOS output type is selected See Fig. 8.		tSCKH(2) +2tCYC		tSCKH(2) + (25/3)tCYC	

Note 4-1-1: These specifications are theoretical values. Margins must be allowed according to the actual operating conditions.

Note 4-1-2: In an application where the serial clock input is to be used in the continuous data transfer mode, the time from SI0RUN being set when serial clock is high to the falling edge of the first serial clock must be longer than tSCKHA.

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	Б	Parameter	Symbol	Pin/	Conditions			Spec	ification	
		rarameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
Serial input		ta setup time	tsDI(1)	SB0(P11), SI0(P11)	Must be specified with respect to rising edge of SIOCLK. See Fig. 8.	0.74- 5.5	0.03			
Serial	Da	ta hold time	thDI(1)			2.7 to 5.5	0.03			
	clock	Output delay time	tdD0(1)	SO0(P10), SB0(P11)	Continuous data transfer mode (Note 4-1-3)				(1/3)tCYC +0.05	μs
Serial output	Input clock		tdD0(2)		Synchronous 8-bit mode (Note 4-1-3)	2.7 to 5.5			1tCYC +0.05	
Seria	Output clock		tdD0(3)		(Note 4-1-3)				(1/3)tCYC +0.05	

Note 4-1-3: Must be specified with respect to falling edge of SIOCLK.

Must be specified as the time to the beginning of output state change in open drain output mode. See Fig. 8.

2. SIO1 Serial I/O Characteristics (Note 4-2-1)

		Parameter	0	Pin/	Conditions			Spec	ification	
		Parameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
	×	Frequency	tSCK(3)	SCK1(P15)	See Fig. 8.		2			
	Input clock	Low level pulse width	tSCKL(3)			2.7 to 5.5	1			10)(0
Serial clock	In	High level pulse width	tSCKH(3)				1			tCYC
Serial	ock	Frequency	tSCK(4)	SCK1(P15)	When CMOS output type is selected		2			
	Output clock	Low level pulse width	tSCKL(4)		• See Fig. 8.	2.7 to 5.5		1/2		tSCK
	0	High level pulse width	tSCKH(4)					1/2		ISCK
Serial input	Da	ata setup time	tsDI(2)	SB1(P14), SI1(P14)	Must be specified with respect to rising edge of SIOCLK. See Fig. 8.	0.71. 5.5	0.03			
Serial	Da	ata hold time	thDI(2)			2.7 to 5.5	0.03			
Serial output	Ou	itput delay time	tdD0(4)	SO1(P13), SB1(P14)	Must be specified with respect to falling edge of SIOCLK. Must be specified as the time to the beginning of output state change in open drain output mode. See Fig. 8.	2.7 to 5.5			(1/3)tCYC +0.05	μѕ

Note 4-2-1: These specifications are theoretical values. Margins must be allowed according to the actual operating conditions.

3. SIO4 Serial I/O Characteristics (Note 4-3-1)

	F	Parameter	Symbol	Pin/	Conditions			Spec	ification	
		arameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
		Frequency	tSCK(5)	SCK4(P24)	See Fig. 8.		2			
		Low level	tSCKL(5)				1			
		pulse width								
		High level	tSCKH(5)				1			
		pulse width	tSCKHA(5a)		USB, SIO0 continuous transfer					
					mode, AIF, SIO9, and DMCOPY not used at the same time.		4			
					• See Fig. 8.		4			
					• (Note 4-3-2)					
	Input clock		tSCKHA(5b)		USB used at the same time					
	onto				SIO0 continuous transfer mode,	2.7 to 5.5				tCYC
	'n				AIF, SIO9, DMCOPY not used at		7			10.0
					the same time.		•			
					• See Fig. 8.					
			tSCKHA(5c)		(Note 4-3-2) USB, SIO0 continuous transfer					
			ISCRIA(SC)		mode, SIO9, and DMCOPY used					
					at the same time.					
					AIF not used at the same time.		12			
					• See Fig. 8.					
					• (Note 4-3-2)					
Serial clock		Frequency	tSCK(6)	SCK4(P24)	When CMOS output type is		4/3			
ialo		Low level	tSCKL(6)		selected. • See Fig. 8.			1/2		
Ser		pulse width	+CCKI I(C)		Gee Fig. 6.					tSCK
		High level pulse width	tSCKH(6)					1/2		
			tSCKHA(6a)		USB, SIO0 continuous transfer					
					mode, AIF, SIO9, and DMCOPY		tSCKH(6)		tSCKH(6)	
					not used at the same time.		+		+	
					When CMOS output type is		(5/3)tCYC		(10/3)tCYC	
					selected. • See Fig. 8.					
	Output clock		tSCKHA(6b)		USB used at the same time.					
	ont o		(00)		SIO0 continuous transfer mode,	2.7 to 5.5				
	Outp				AIF, SIO9, and DMCOPY not		tSCKH(6)		tSCKH(6)	
					used at the same time.		+		+	tCYC
					When CMOS output type is		(5/3)tCYC		(19/3)tCYC	1010
					selected.					
			+COKI IA (C-)		• See Fig. 8.					
			tSCKHA(6c)		USB, SIO0 continuous transfer mode, SIO9, and DMCOPY used					
					at the same time.		tSCKH(6)		tSCKH(6)	
					AIF not used at the same time.		+		+	
					When CMOS output type is		(5/3)tCYC		(34/3)tCYC	
					selected.					
		2 1. Than an	a sifications		• See Fig. 8.					

Note 4-3-1: These specifications are theoretical values. Margins must be allowed according to the actual operating conditions.

Note 4-3-2: In an application where the serial clock input is to be used in the continuous data transfer mode, the time from SI4RUN being set when serial clock is high to the falling edge of the first serial clock must be longer than tSCKHA.

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	Parameter	Symbol	Pin/	Conditions			Speci	ification	
	Farameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
input	Data setup time	tsDI(3)	SO4(P22), SI4(P23)	Must be specified with respect to rising edge of SIOCLK. See Fig. 8	0.71.55	0.03			
Serial	Data hold time	thDI(3)			2.7 to 5.5	0.03			
Serial output	Output delay time	tdD0(5)	SO4(P22), SI4(P23)	Must be specified with respect to falling edge of SIOCLK. Must be specified as the time to the beginning of output state change in open drain output mode. See Fig. 8.	2.7 to 5.5			(1/3)tCYC +0.05	μs

4. SIO9 Serial I/O Characteristics (Note 4-4-1)

	-	arameter	Cumahal	Pin/	Conditions			Specifi	cation	
		rarameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
		Frequency	tSCK(7)	SCK9(P27)	See Fig. 8.		2			
		Low level pulse width	tSCKL(7)				1			
		High level pulse width	tSCKH(7)				1			
lock	lock		tSCKHA(7a)		USB, SIO0 continuous transfer mode, AIF, SIO4 and DMCOPY not used at the same time. See Fig. 8. (Note 4-4-2)		4			
Serial clock	Input clock		tSCKHA(7b)		USB used at the same time. SIO0 continuous transfer mode, AIF, SIO4, and DMCOPY not used at the same time. See Fig. 8. (Note 4-4-2)	2.7 to 5.5	7			tCYC
			tSCKHA(7c)		USB, SIO0 continuous transfer mode, SIO4 and DMCOPY used at the same time. AIF not used at the same time. See Fig. 8. (Note 4-4-2)		15			

Note 4-4-1: These specifications are theoretical values. Margins must be allowed according to the actual operating conditions.

Note 4-4-2: In an application where the serial clock input is to be used in the continuous data transfer mode, the time from SI9RUN being set when serial clock is high to the falling edge of the first serial clock must be longer than tSCKHA.

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Con		ed from precedin		Pin/				Specif	ication	
	F	Parameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
		Frequency	tSCK(8)	SCK9(P27)	When CMOS output type is selected.		4/3			tCYC
		Low level pulse width	tSCKL(8)		• See Fig. 8.			1/2		tSCK
		High level pulse width	tSCKH(8)					1/2		ISCK
×	ck		tSCKHA(8a)		USB, SIO0 continuous transfer mode, AIF, SIO4, and DMCOPY not used at the same time. When CMOS output type is selected. See Fig. 8.		tSCKH(8) + (5/3)tCYC		tSCKH(8) + (10/3)tCYC	
Serial clock	Output clock		tSCKHA(8b)		USB used at the same time. SIO0 continuous transfer mode, AIF, SIO4, and DMCOPY not used at the same time. When CMOS output type is selected See Fig. 8.	2.7 to 5.5	tSCKH(8) + (5/3)tCYC		tSCKH(8) + (19/3)tCYC	tCYC
			tSCKHA(8c)		USB, SIO0 continuous transfer mode, SIO4, and DMCOPY used at the same time. AIF not used at the same time. When CMOS output type is selected. See Fig. 8.		tSCKH(8) + (5/3)tCYC		tSCKH(8) + (43/3)tCYC	
input	Da	ta setup time	tsDI(4)	SO9(P25), SI9(P26)	Must be specified with respect to rising edge of SIOCLK. See Fig. 8.		0.03			
Serial input	Da	ta hold time	thDI(4)			2.7 to 5.5	0.03			
Serial output	Ou	tput delay time	tdDO(6)	SO9(P25), SI9(P26)	Must be specified with respect to falling edge of SIOCLK. Must be specified as the time to the beginning of output state change in open drain output mode See Fig. 8.	2.7 to 5.5			(1/3)tCYC +0.05	μs

Pulse Input Conditions at Ta = -40°C to +85°C, $V_SS1 = V_SS2 = V_SS3 = 0V$

Parameter	Symbol	Pin/Remarks	Conditions			Speci	fication	
Parameter	Symbol	Pin/Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
High/low level pulse width	tP1H(1) tP1L(1)	INT0(P70), INT1(P71), INT2(P72), INT4(P20 to P23), INT5(P24 to P27), INT6(P20), INT7(P24)	Interrupt source flag can be set. Event inputs for timer 0 or 1 are enabled.	2.7 to 5.5	1			
	tPIH(2) tPIL(2)	INT3(P73) when noise filter time constant is 1/1	Interrupt source flag can be set. Event inputs for timer 0 are enabled.	2.7 to 5.5	2			tCYC
	tPIH(3) tPIL(3)	INT3(P73) when noise filter time constant is 1/32	Interrupt source flag can be set.Event inputs for timer 0 are nabled.	2.7 to 5.5	64			
	tPIH(4) tPIL(4)	INT3(P73) when noise filter time constant is 1/128	Interrupt source flag can be set.Event inputs for timer 0 are enabled.	2.7 to 5.5	256			
	tPIL(5)	RMIN(P73)	Recognized by the infrared remote control receiver circuit as a signal	2.7 to 5.5	4			RMCK (Note 5-1)
	tPIL(6)	RES	Resetting is enabled.	2.7 to 5.5	200			μs

Note 5-1: Represents the period of the reference clock (1 tCYC to 128 tCYC or the source frequency of the subclock) for the infrared remote control receiver circuit.

AD Converter Characteristics at $Ta = -40^{\circ}C$ to $+85^{\circ}C$, $V_{SS}1 = V_{SS}2 = V_{SS}3 = 0V$

			ut 1u 10 0 to 100 0,	. 55-	, 29 -	່ນວ	• .	
Parameter	Cumbal	Pin/Remarks	Conditions			Specifi	cation	
Parameter	Symbol	Pili/Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
Resolution	N	AN0(P00) to		3.0 to 5.5		8		bit
Absolute accuracy	ET	AN7(P07), AN8(P70),	(Note 6-1)	3.0 to 5.5			±1.5	LSB
Conversion time	TCAD	AN9(P71),	AD conversion time=32×tCYC		15.68		97.92	
		AN10(XT1),	(when ADCR2=0) (Note 6-2)	4.5 to 5.5	(tCYC=		(tCYC=	
		AN11(XT2)			0.490µs)		3.06µs)	
					23.52		97.92	
				3.0 to 5.5	(tCYC=		(tCYC=	
					0.735µs)		3.06µs)	
			AD conversion time=64×tCYC		18.82		97.92	μs
			(when ADCR2=1) (Note 6-2)	4.5 to 5.5	(tCYC=		(tCYC=	
					0. 294µs)		1.53µs)	
					47.04		97.92	
				3.0 to 5.5	(tCYC=		(tCYC=	
					0.735µs)		1.53µs)	
Analog input voltage range	VAIN			3.0 to 5.5	V _{SS}		V_{DD}	V
Analog port	IAINH		VAIN=V _{DD}	3.0 to 5.5			1	
input current	IAINL		VAIN=V _{SS}	3.0 to 5.5	-1			μΑ

Note 6-1: The quantization error ($\pm 1/2$ LSB) is excluded from the absolute accuracy.

Note 6-2: The conversion time refers to the period from the time when an instruction for starting a conversion process is issued to the time the conversion results register(s) are loaded with a complete digital conversion value corresponding to the analog input value.

$\textbf{Consumption Current Characteristics} \ \, \text{at } Ta = -40^{\circ}C \ \, \text{to} \ \, +85^{\circ}C, \ \, V_{SS}1 = V_{SS}2 = V_{SS}3 = 0V$

_	_	Pin/	_			Specif	ication	
Parameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
Normal mode consumption current (Note 7-1)	IDDOP(1)	V _{DD} 1 =V _{DD} 2 =V _{DD} 3	FmCF=12MHz ceramic oscillation mode FsX'tal=32.768kHz crystal oscillation mode System clock set to 12MHz side Internal PLL oscillation stopped	4.5 to 5.5		9.8	24	
(Note 7-1)	IDDOP(2)		Internal RC oscillation stopped USB circuit stopped 1/1 frequency division ratio	3.0 to 3.6		5.7	14	
	IDDOP(3)		FmCF=12MHz ceramic oscillation mode FsX'tal=32.768kHz crystal oscillation mode System clock set to 12MHz side	4.5 to 5.5		15	35	
	IDDOP(4)		Internal PLL oscillation mode active Internal RC oscillation stopped USB circuit active 1/1 frequency division ratio	3.0 to 3.6		7.7	20	mA
	IDDOP(5)		FmCF=12MHz ceramic oscillation mode	4.5 to 5.5		6.7	16	
	IDDOP(6)	=	FsX'tal=32.768kHz crystal oscillation mode System clock set to 6MHz side	3.0 to 3.6		3.9	9.0	
	IDDOP(7)	-	Internal RC oscillation stopped 1/2 frequency division ratio	2.7 to 3.0		3.2	7.3	
	IDDOP(8)		FmCF=0Hz (oscillation stopped)	4.5 to 5.5		0.72	3.4	
	IDDOP(9)		 FsX'tal=32.768kHz crystal oscillation mode System clock set to internal RC oscillation. 	3.0 to 3.6		0.41	1.9	
	IDDOP(10)		1/2 frequency division ratio	2.7 to 3.0		0.35	1.5	
	IDDOP(11)		FmCF=0Hz (oscillation stopped) FsX'tal=32.768kHz crystal oscillation mode	4.5 to 5.5		45	184	
	IDDOP(12)		System clock set to crystal oscillation. (32.768kHz)	3.0 to 3.6		18	65	μΑ
	IDDOP(13)		Internal RC oscillation stopped 1/2 frequency division ratio	2.7 to 3.0		14	47	
HALT mode consumption current (Note7-1)	IDDHALT(1)		HALT mode FmCF=12MHz ceramic oscillation mode FsX'tal=32.768kHz crystal oscillation mode System clock set to 12MHz side	4.5 to 5.5		4.9	12	
	IDDHALT(2)		Internal PLL oscillation stopped Internal RC oscillation stopped USB circuit stopped 1/1 frequency division ratio	3.0 to 3.6		2.7	6.4	
	IDDHALT(3)		HALT mode FmCF=12MHz ceramic oscillation mode FsX'tal=32.768kHz crystal oscillation mode System clock set to 12MHz side	4.5 to 5.5		9.5	23	
	IDDHALT(4)		Internal PLL oscillation mode active Internal RC oscillation stopped USB circuit active I/1 frequency division ratio	3.0 to 3.6		4.7	12	mA
	IDDHALT(5)		HALT mode FmCF=12MHz ceramic oscillation mode	4.5 to 5.5		3.0	7.3	
	IDDHALT(6)		FsX'tal=32.768kHz crystal oscillation mode System clock set to 6MHz side	3.0 to 3.6		1.6	3.8	
	IDDHALT(7)		Internal RC oscillation stopped 1/2 frequency division ratio	2.7 to 3.0		1.3	2.9	
	IDDHALT(8)	1	• HALT mode	4.5 to 5.5		0.41	2.0	
	IDDHALT(9)]	FmCF=0Hz (oscillation stopped) FsX'tal=32.768kHz crystal oscillation mode	3.0 to 3.6		0.20	0.95	
	IDDHALT(10)		System clock set to internal RC oscillation. 1/2 frequency division ratio	2.7 to 3.0		0.17	0.70	

Note 7-1: The consumption current value includes none of the currents that flow into the output Tr and internal pull-up resistors.

Continued on next page.

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Parameter	Cumbal	Pin/	Conditions			Specif	ication	
Parameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
HALT mode consumption	IDDHALT(11)	V _{DD} 1 =V _{DD} 2	HALT mode FmCF=0Hz (oscillation stopped)	4.5 to 5.5		31	132	
current (Note 7-1)	IDDHALT(12)	=V _{DD} 3	FsX'tal=32.768kHz crystal oscillation mode System clock set to crystal oscillation.	3.0 to 3.6		9.1	39	
	IDDHALT(13)		(32.768kHz) Internal RC oscillation stopped 1/2 frequency division ratio	2.7 to 3.0		6.3	27	
HOLD mode	IDDHOLD(1)	V _{DD} 1	HOLD mode	4.5 to 5.5		0.14	39	μΑ
consumption	IDDHOLD(2)		CF1=V _{DD} or open (External clock mode)	3.0 to 3.6		0.04	19	
current	IDDHOLD(3)			2.7 to 3.0		0.04	17	
Timer HOLD	IDDHOLD(4)		Timer HOLD mode	4.5 to 5.5		25	115	
mode	IDDHOLD(5)		CF1=V _{DD} or open (External clock mode)	3.0 to 3.6		6.0	32	
consumption current	IDDHOLD(6)		FsX'tal=32.768kHz crystal oscillation mode	2.7 to 3.0		3.7	20	

Note 7-1: The consumption current value includes none of the currents that flow into the output Tr and internal pull-up resistors

USB Characteristics and Timing at $Ta = -40^{\circ}C$ to $+85^{\circ}C$, $V_SS1 = V_SS2 = V_SS3 = 0V$

		Conditions		Specifi		
Parameter	Symbol	Conditions	min	typ	max	unit
High level output	V _{OH(USB)}	• 15kΩ±5% to GND	2.8		3.6	V
Low level output	V _{OL(USB)}	• 1.5kΩ±5% to 3.6V	0.0		0.3	V
Output signal crossover voltage	V _{CRS}		1.3		2.0	V
Differential input sensitivity	V _{DI}	• (UHD+)-(UHD-)	0.2			V
Differential input common mode range	V _{CM}		0.8		2.5	V
High level input	V _{IH(USB)}		2.0			V
Low level input	V _{IL(USB)}				0.8	V
USB data rise time	t _R	• R _S =33Ω, C _L =50pF	4		20	ns
USB data fall time	t _F	• R _S =33Ω, C _L =50pF	4		20	ns

F-ROM Programming Characteristics at $Ta = +10^{\circ}C$ to $+55^{\circ}C$, $V_{SS}1 = 0V$

Parameter	Cumabal	Pin/	Conditions		Specification			
Parameter	Symbol	Remarks	Conditions	V _{DD} [V]	min	typ	max	unit
Onboard programming current	IDDFW(1)	V _{DD} 1	Excluding power dissipation in the microcontroller block	3.0 to 5.5		5	10	mA
Programming time	tFW(1)		Erase operation	204-55		20	30	ms
	tFW(2)	FW(2) • Write operation		3.0 to 5.5		40	60	μs

Characteristics of a Sample Main System Clock Oscillation Circuit

Given below are the characteristics of a sample main system clock oscillation circuit that are measured using a SANYO-designated oscillation characteristics evaluation board and external components with circuit constant values with which the oscillator vendor confirmed normal and stable oscillation.

Table 1 shows the characteristics of a oscillation circuit when USB host function is not used.

If USB host function is to be used, it is absolutely recommended to use an oscillator that satisfies the precision and stability according to the USB standards.

Nominal Vendor Frequency Name	Oscillator Name	Circuit Constant			Operating Voltage	Oscillation Stabilization Time			
		C1 [pF]	C2 [pF]	Rd1 [Ω]	Range [V]	typ [ms]	max [ms]	Remarks	
6MHz	MURATA	CSTCR6M00GH5L**-R0	(39)	(39)	1k	2.7 to 5.5	0.1	0.5	C1 and C2 integrated SMD type
8MHz	MURATA	CSTCE8M00GH5L**-R0	(33)	(33)	470	3.0 to 5.5	0.1	0.5	
10MHz	MURATA	CSTCE10M0GH5L**-R0	(33)	(33)	330	3.0 to 5.5	0.1	0.5	
12MHz	MURATA	CSTCE12M0GH5L**-R0	(33)	(33)	330	3.0 to 5.5	0.1	0.5	

The oscillation stabilization time refers to the time interval that is required for the oscillation to get stabilized in the following cases (see Figure 4):

- Till the oscillation gets stabilized after VDD goes above the operating voltage lower limit.
- Till the oscillation gets stabilized after the instruction for starting the main clock oscillation circuit is executed
- Till the oscillation gets stabilized after the HOLD mode is reset.
- Till the oscillation gets stabilized after the X'tal HOLD mode is reset with CFSTOP (OCR register, bit 0) set to 0

Characteristics of a Sample Subsystem Clock Oscillator Circuit

Given below are the characteristics of a sample subsystem clock oscillation circuit that are measured using a SANYO-designated oscillation characteristics evaluation board and external components with circuit constant values with which the oscillator vendor confirmed normal and stable oscillation.

Table 2 Characteristics of a Sample Subsystem Clock Oscillator Circuit with a Crystal Oscillator

Nominal Vendor Frequency Name	Vendor		Circuit Constant				Operating Voltage	Oscillation Stabilization Time		
	Oscillator Name	C3	C4	Rf	Rd2	Range typ max		max	Remarks	
			[pF]	[pF]	$[\Omega]$	$[\Omega]$	[V]	[s]	[s]	
	EPSON									Applicable
32.768kHz	TOYOCOM	MC-306	18	18	OPEN	560k	2.7 to 5.5	1.1	3.0	CL value=12.5pF
	101000111									SMD type

The oscillation stabilization time refers to the time interval that is required for the oscillation to get stabilized in the following cases (see Figure 4):

- Till the oscillation gets stabilized after the instruction for starting the subclock oscillation circuit is executed
- Till the oscillation gets stabilized after the HOLD mode is reset with EXTOSC (OCR register, bit 6) set to 1

Note: The components that are involved in oscillation should be placed as close to the IC and to one another as possible because they are vulnerable to the influences of the circuit pattern.

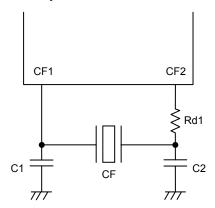


Figure 1 CF Oscillator Circuit

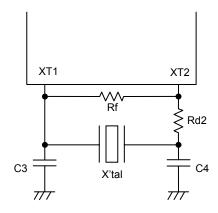
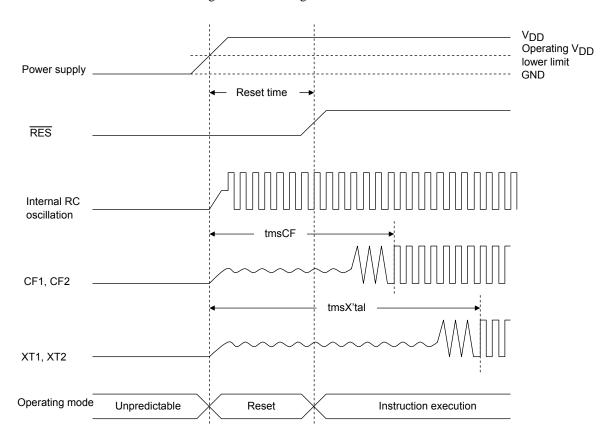


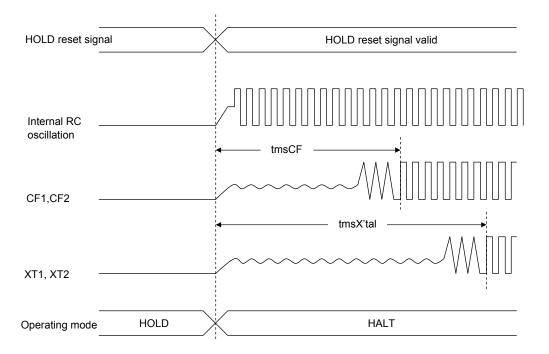
Figure 2 Crystal Oscillator Circuit



Figure 3 AC Timing Measurement Point

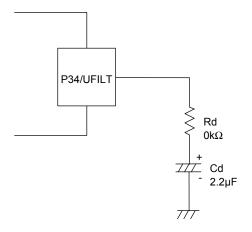


Reset Time and Oscillation Stabilization Time



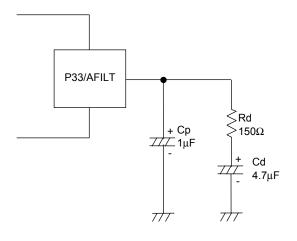
HOLD Reset Signal and Oscillation Stabilization Time

Figure 4 Oscillation Stabilization Time



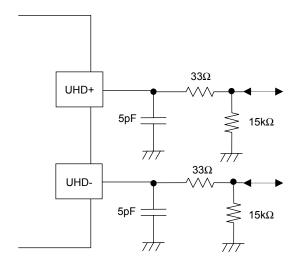
When using the internal PLL circuit to generate the $48 MHz\ clock$ for USB , it is necessary to connect a filter circuit such to the P34/UFILT pin such as that shown in the left Fig.

Figure 5 External Filter Circuit for the Internal USB-dedicated PLL Circuit



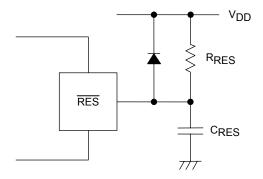
To generate the master clock for the audio interface using the internal PLL circuit, it is necessary to connect a filter circuit to the P33/AFILT pin that is shown in the left Fig.

Figure 6 External Filter Circuit for Audio Interface (Used with Internal PLL Circuit)



It's necessary to adjust the Circuit Constant of the USB Port Peripheral Circuit for each mounting board.

Figure 7 USB Port Peripheral Circuit



Note:

Determine the value of CRES and RRES so that the reset signal is present for a period of 200µs after the supply voltage goes beyond the lower limit of the IC's operating voltage.

Figure 8 Reset Circuit

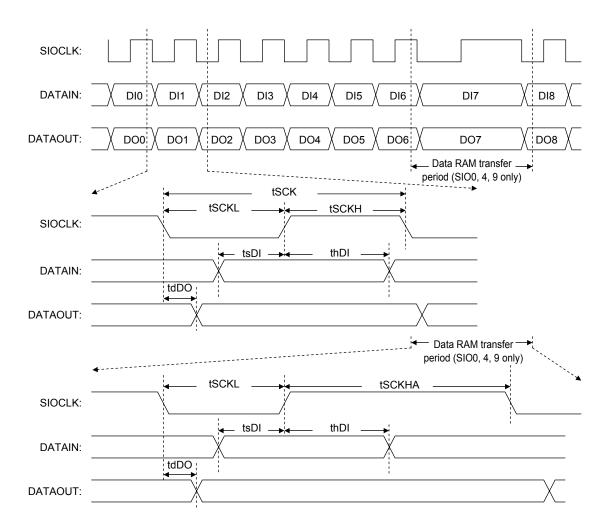


Figure 9 Serial I/O Waveform

Figure 10 Pulse Input Timing Signal Waveform

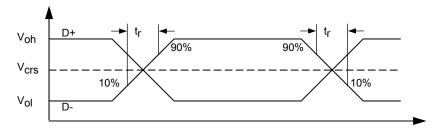


Figure 11 USB Data Signal Timing and Voltage Level

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